

Notice of References Cited	Application/Control No. 10/049,456		Applicant(s)/Patent Under Reexamination LURIE ET AL.	
	Examiner Rene Towa		Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,088,135 A	05-1978	O'Neill, William J.	604/100.01
*	B	US-4,182,328 A	01-1980	Bolduc et al.	604/515
*	C	US-4,468,216 A	08-1984	Muto, Rudolph	604/43
*	D	US-4,533,345 A	08-1985	Louw, John A.	604/43
*	E	US-4,744,789 A	05-1988	Johnson, Gerald W.	604/218
*	F	US-4,932,947 A	06-1990	Cardwell, Dieter W.	604/198
*	G	US-5,007,903 A	04-1991	Ellard, Terence R.	604/195
*	H	US-5,338,297 A	08-1994	Kocur et al.	604/103.03
*	I	US-5,494,044 A	02-1996	Sundberg, Karin	600/562
*	J	US-5,624,399 A	04-1997	Ackerman, Bernard	604/103.03
*	K	US-5,836,921 A	11-1998	Mahurkar, Sakham D.	604/195
*	L	US-6,146,373 A	11-2000	Cragg et al.	604/523
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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